

# FDS5690

## 60V N-Channel PowerTrench® MOSFET

### General Description

This N-Channel MOSFET is produced using Fairchild Semiconductor's advanced PowerTrench process that has been especially tailored to minimize on-state resistance and yet maintain superior switching performance.

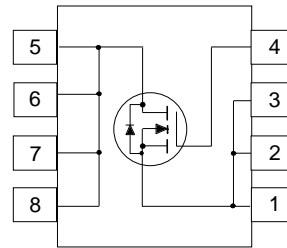
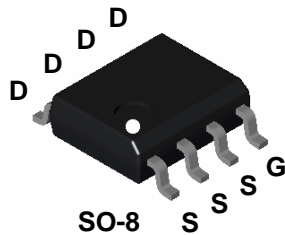
These devices are well suited for low voltage and battery powered applications where low in-line power loss and fast switching are required.

### Applications

- DC/DC converter
- Motor drives

### Features

- 7 A, 60 V.  $R_{DS(on)} = 0.028 \Omega @ V_{GS} = 10 \text{ V}$   
 $R_{DS(on)} = 0.033 \Omega @ V_{GS} = 6 \text{ V}$ .
- Low gate charge (23nC typical).
- Fast switching speed.
- High performance trench technology for extremely low  $R_{DS(on)}$ .
- High power and current handling capability.



### Absolute Maximum Ratings T<sub>A</sub> = 25°C unless otherwise noted

| Symbol                            | Parameter  | Ratings     | Units |
|-----------------------------------|--|-------------|-------|
| V <sub>DSS</sub>                  | Drain-Source Voltage                             | 60          | V     |
| V <sub>GSS</sub>                  | Gate-Source Voltage                              | ±20         | V     |
| I <sub>D</sub>                    | Drain Current - Continuous (Note 1a)             | 7           | A     |
|                                   |  | 50          |       |
| P <sub>D</sub>                    | Power Dissipation for Single Operation (Note 1a) | 2.5         | W     |
|                                   |  | 1.2         |       |
|                                   |  | 1           |       |
| T <sub>J</sub> , T <sub>stg</sub> | Operating and Storage Junction Temperature Range | -55 to +150 | °C    |

### Thermal Characteristics

|                  |   |    |      |
|------------------|---|----|------|
| R <sub>θJA</sub> | Thermal Resistance, Junction-to-Ambient (Note 1a) | 50 | °C/W |
| R <sub>θJC</sub> | Thermal Resistance, Junction-to-Case (Note 1)     | 25 | °C/W |

### Package Outlines and Ordering Information

| Device Marking | Device  | Reel Size | Tape Width | Quantity   |
|----------------|---------|-----------|------------|------------|
| FDS5690        | FDS5690 | 13"       | 12mm       | 2500 units |

## DMOS Electrical Characteristics

$T_A = 25^\circ\text{C}$  unless otherwise noted

| Symbol | Parameter | Test Conditions | Min | Typ | Max | Units |
|--------|-----------|-----------------|-----|-----|-----|-------|
|--------|-----------|-----------------|-----|-----|-----|-------|

### Off Characteristics

|                                      |   |   |    |    |      |                      |
|--------------------------------------|---|---|----|----|------|----------------------|
| $BV_{DSS}$                           | Drain-Source Breakdown Voltage            | $V_{GS} = 0\text{ V}, I_D = 250\ \mu\text{A}$               | 60 |    |      | V                    |
| $\frac{\Delta BV_{DSS}}{\Delta T_j}$ | Breakdown Voltage Temperature Coefficient | $I_D = 250\ \mu\text{A}$ , Referenced to $25^\circ\text{C}$ |    | 57 |      | mV/ $^\circ\text{C}$ |
| $I_{DSS}$                            | Zero Gate Voltage Drain Current           | $V_{DS} = 48\text{ V}, V_{GS} = 0\text{ V}$                 |    |    | 1    | $\mu\text{A}$        |
| $I_{GSSF}$                           | Gate-Body Leakage Current, Forward        | $V_{GS} = 20\text{ V}, V_{DS} = 0\text{ V}$                 |    |    | 100  | nA                   |
| $I_{GSSR}$                           | Gate-Body Leakage Current, Reverse        | $V_{GS} = -20\text{ V}, V_{DS} = 0\text{ V}$                |    |    | -100 | nA                   |

### On Characteristics (Note 2)

|  |  |  |    |                         |                         |                      |
|--|--|--|----|-------------------------|-------------------------|----------------------|
| $V_{GS(th)}$                           | Gate Threshold Voltage                         | $V_{DS} = V_{GS}, I_D = 250\ \mu\text{A}$  | 2  | 2.5                     | 4                       | V                    |
| $\frac{\Delta V_{GS(th)}}{\Delta T_j}$ | Gate Threshold Voltage Temperature Coefficient | $I_D = 250\ \mu\text{A}$ , Referenced to $25^\circ\text{C}$  |    | -5.9                    |                         | mV/ $^\circ\text{C}$ |
| $R_{DS(on)}$                           | Static Drain-Source On-Resistance              | $V_{GS} = 10\text{ V}, I_D = 7\text{ A}$<br>$V_{GS} = 10\text{ V}, I_D = 7\text{ A}, T_J = 125^\circ\text{C}$<br>$V_{GS} = 6\text{ V}, I_D = 6.5\text{ A}$ |    | 0.022<br>0.037<br>0.025 | 0.028<br>0.050<br>0.033 | $\Omega$             |
| $I_{D(on)}$                            | On-State Drain Current                         | $V_{GS} = 10\text{ V}, V_{DS} = 5\text{ V}$  | 25 |                         |                         | A                    |
| $g_{FS}$                               | Forward Transconductance                       | $V_{DS} = 10\text{ V}, I_D = 7\text{ A}$   |    | 24                      |                         | S                    |

### Dynamic Characteristics

|           |                              |  |  |      |  |    |
|-----------|------------------------------|--|--|------|--|----|
| $C_{iss}$ | Input Capacitance            | $V_{DS} = 30\text{ V}, V_{GS} = 0\text{ V},$<br>$f = 1.0\text{ MHz}$ |  | 1107 |  | pF |
| $C_{oss}$ | Output Capacitance           |  |  | 149  |  | pF |
| $C_{rss}$ | Reverse Transfer Capacitance |  |  | 72   |  | pF |

### Switching Characteristics (Note 2)

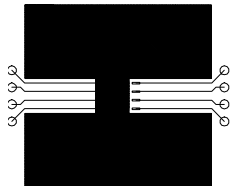
|              |                     |  |  |     |    |    |
|--------------|---------------------|--|--|-----|----|----|
| $t_{d(on)}$  | Turn-On Delay Time  | $V_{DD} = 30\text{ V}, I_D = 1\text{ A},$<br>$V_{GS} = 10\text{ V}, R_{GEN} = 6\ \Omega$ |  | 10  | 18 | ns |
| $t_r$        | Turn-On Rise Time   |  |  | 9   | 18 | ns |
| $t_{d(off)}$ | Turn-Off Delay Time |  |  | 24  | 39 | ns |
| $t_f$        | Turn-Off Fall Time  |  |  | 10  | 18 | ns |
| $Q_g$        | Total Gate Charge   | $V_{DS} = 30\text{ V}, I_D = 7\text{ A},$<br>$V_{GS} = 10\text{ V},$                     |  | 23  | 32 | nC |
| $Q_{gs}$     | Gate-Source Charge  |  |  | 4   |    | nC |
| $Q_{gd}$     | Gate-Drain Charge   |  |  | 6.8 |    | nC |

### Drain-Source Diode Characteristics and Maximum Ratings

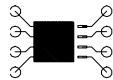
|          |   |  |  |      |     |   |
|----------|---|--|--|------|-----|---|
| $I_S$    | Maximum Continuous Drain-Source Diode Forward Current |  |  | 2.1  |     | A |
| $V_{SD}$ | Drain-Source Diode Forward Voltage                    | $V_{GS} = 0\text{ V}, I_S = 2.1\text{ A}$ (Note 2) |  | 0.75 | 1.2 | V |

#### Notes:

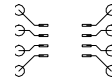
- $R_{\theta JA}$  is the sum of the junction-to-case and case-to-ambient resistance where the case thermal reference is defined as the solder mounting surface of the drain pins.  $R_{\theta JC}$  is guaranteed by design while  $R_{\theta JA}$  is determined by the user's board design.



a)  $50^\circ\text{ C/W}$  when mounted on a  $0.5\text{ in}^2$  pad of 2 oz. copper.



b)  $105^\circ\text{ C/W}$  when mounted on a  $0.02\text{ in}^2$  pad of 2 oz. copper.



c)  $125^\circ\text{ C/W}$  when mounted on a  $0.003\text{ in}^2$  pad of 2 oz. copper.

Scale 1 : 1 on letter size paper

- Pulse Test: Pulse Width  $\leq 300\ \mu\text{s}$ , Duty Cycle  $\leq 2.0\%$

Typical Characteristics

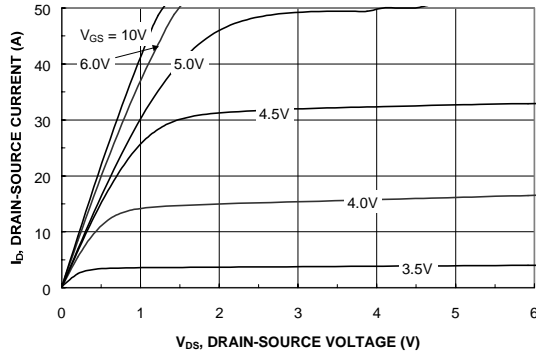


Figure 1. On-Region Characteristics.

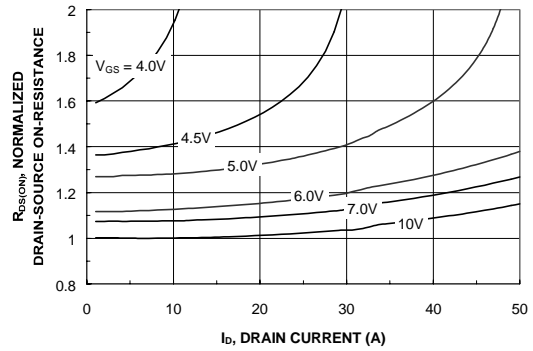


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

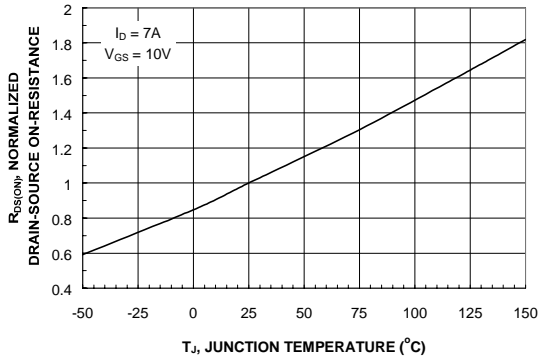


Figure 3. On-Resistance Variation with Temperature.

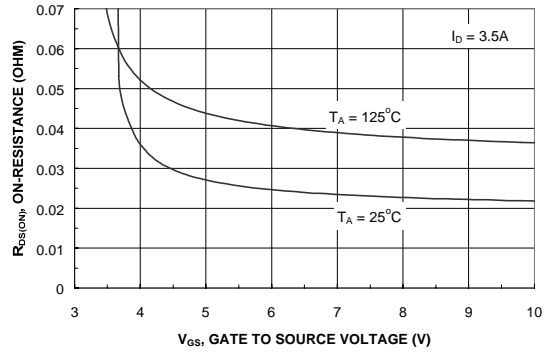


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

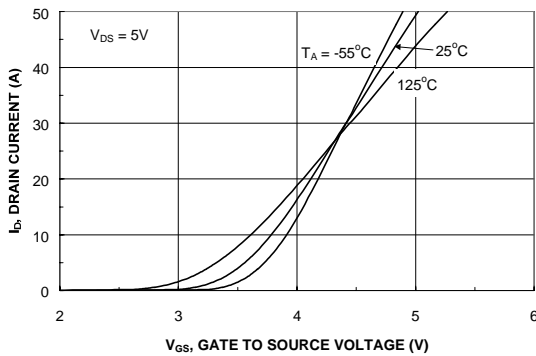


Figure 5. Transfer Characteristics.

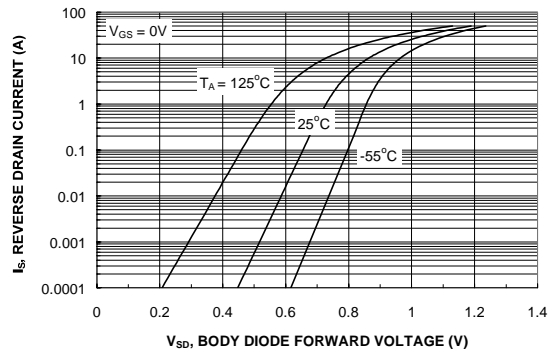
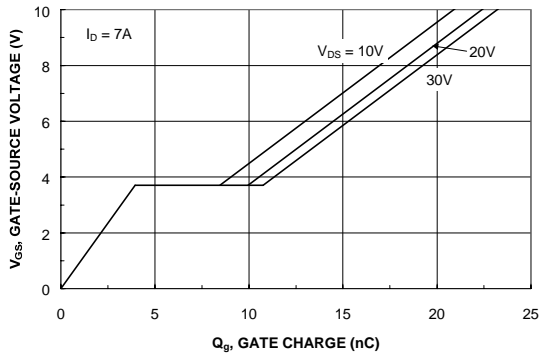
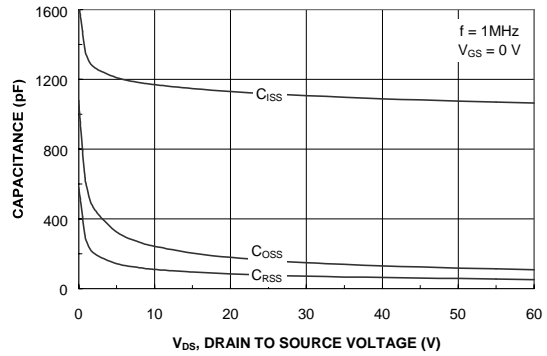


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

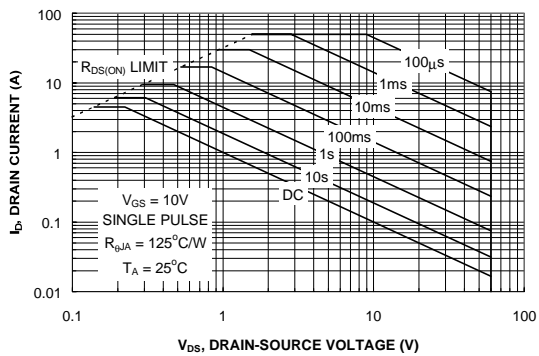
**Typical Characteristics** (continued)



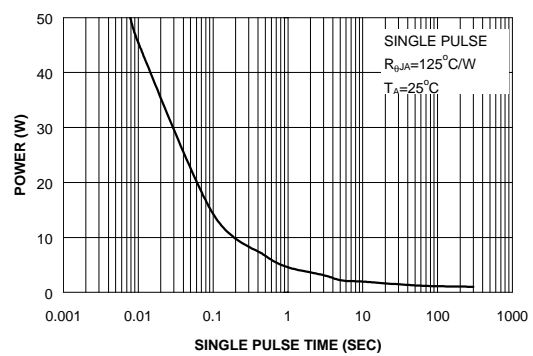
**Figure 7. Gate Charge Characteristics.**



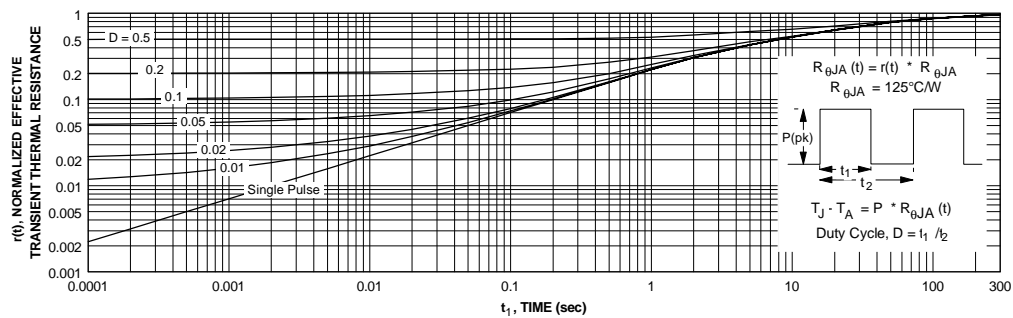
**Figure 8. Capacitance Characteristics.**



**Figure 9. Maximum Safe Operating Area.**



**Figure 10. Single Pulse Maximum Power Dissipation.**



**Figure 11. Transient Thermal Response Curve.**

Thermal characterization performed using the conditions described in Note 1c.  
 Transient thermal response will change depending on the circuit board design.

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| E <sup>2</sup> CMOS™ | PowerTrench®  | VCX™        |
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